

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/724,894	KONNO ET AL.	
Examiner	Art Unit	_
B. Chen	1792	

	SEARCHED				
Class	Subclass	Date	Examiner		
427	146 8 9	12/4/2007	ВС		
427	162 261 265	12/4/2007	ВС		
427	402	12/4/2007	вс		
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· INI	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
427	146 8 9	12/4/2007	ВС	
427	162 261	12/4/2007	ВС	
427	265 402	12/4/2007	вс	
		Bang	692	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
east	12/4/2007	7 BC		